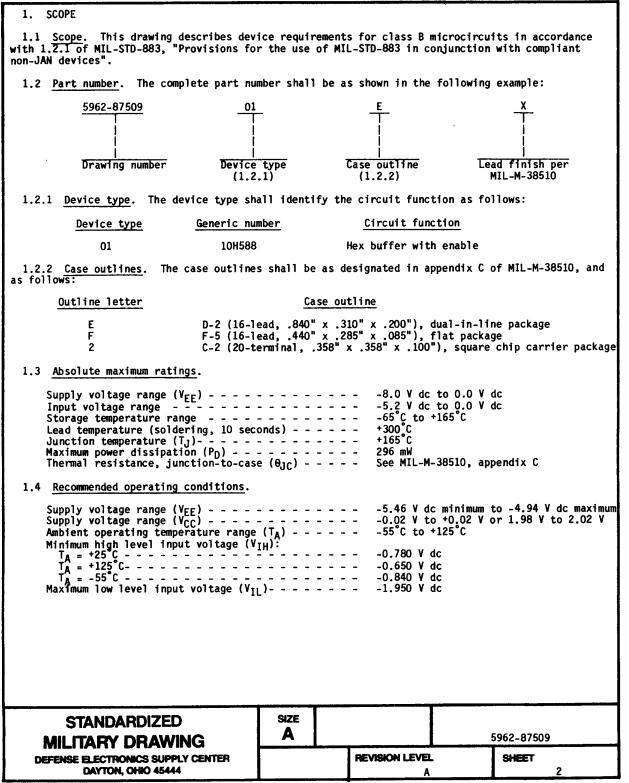
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DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.



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2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MII -M-38510

- Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - 3. REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.2 Truth table. The truth table shall be as specified on figure 2.
 - 3.2.3 <u>Logic diagram</u>. The logic diagram shall be as specified on figure 3.
- 3.2.4 Test circuit and switching waveforms. The test circuit and switching waveforms shall be as specified on figure 4.
 - 3.2.5 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full ambient operating temperature range.
- 3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

STANDARDIZED
MILITARY DRAWING
DEFENSE ELECTRONICS SUPPLY CENTER
DAYTON, OHIO 45444

SIZE
A
5962-87509

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3

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TABLE I. Electrical performance characteristics. Conditions $-55^{\circ}\text{C} < \text{T}_{A} \le +125^{\circ}\text{C}$ unless otherwise specified Group A Unit Test Symbol 1 Limits subgroups Min Max Quiescent tests 1/ Cases E, F, and 2 v_{IL} v_{IH} High level output ļ V_{OH} **Outputs** vol tage terminated -1.010 -0.780 ٧ through -0.780 -1.950 1 100Ω to -2 V -1.950 -0.860 -0.6501 2 -0.650 V_{CC} = 0.0 V V_{EE} = -5.2 V 2/ -1.950 -0.840 -0.840 -1.060 -0.780 -1.950 -1.950 -1.580 Low level output 1 VOL -1.950 -1.950 -1.565 ٧ 2 -0.650 voltage -0.840 -1.950 3 -1.950 -1.610 -1.480 -1.010 -0.7801 -1.110 1 High level threshold AHO -0.6501 ٧ output voltage -0.960 -1.465 2 -0.860 -1.510 -1.060 -0.840-1.160 -1.950 -1.110 -1.480 -1.580| Low level threshold VOLA 1 -1.565 ٧ -1.9501 output voltage -0.960 -1.465 2 -1.160 | -1.510 -1.950| -1.610| VEE = -5.46 V VCC = 0.0 V VIH = -0.780 V at +25°C -0.650 V at +125°C 2, 3 -42 mΑ Power supply drain 3/ current IEE -46 -0.840 V at -55°C $\mu \boldsymbol{A}$ High level input current 310 495 IIH 1, 2 VEE = -4.94 V VIL = -1.950 V 3/ VCC = 0.0 V IIL 1, 3 0.5 μΑ Low level input 0.3 current See 4.3.1c 7,8 Functional tests See footnotes at end of table. **STANDARDIZED** SIZE Α 5962-87509 **MILITARY DRAWING** DEFENSE ELECTRONICS SUPPLY CENTER REVISION LEVEL SHEET DAYTON, OHIO 45444 4

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Test	Symbol	Conditions -55°C < T _A < +125°C		Group A	Limits		Unit	
		-55°C < TA unless other 	<pre>< +125 C wise speci</pre>		subgroups 	Min	Max	
Cases E and F		Ra	pid tests	<u>4</u> /				
High level output	v _{OH}	 Outputs terminated	ΥIH	VIL				
voltage		through 1000 to -2 V Ycc = 0.0 V	-0.793 -0.664 -0.854	-1.950	1 1 2 3	-1.022 -0.873 -1.073	-0.793 -0.664 -0.854	
Low level output voltage	V _{OL}	VEE = -5.2 V <u>2/</u> 	-0.793 -0.664 -0.854		1 1 1 1 2 1 3 1 1 1 1 1 1 1 1 1 1 1 1 1	-1.950 -1.950 -1.950	-1.584 -1.569 -1.614	٧
High level threshold output voltage	V _{OHA}	 	-1.122 -0.973 -1.173	-1.469	1 2 1 3	-1.022 -0.873 -1.073	-0.793 -0.664 -0.854	٧
Low level threshold output voltage	V _{OL} A	- - 	-1.122 -0.973 -1.173	-1.469	1 1 2 3	-1.950 -1.950 -1.950	-1.569	٧
Power supply drain <u>3</u> / current	I I EE	VEE = -5.46 V VCC = 0.0 V V _{IH} = -0.793 V at +25°C -0.664 V at +125°C -0.854 V at -55°C			2, 3	-41 -45		mA
High level input current	IIH	- -			1, 2		295 480	μА
Low level input current	IIL	VEE = -4.94 V VIL = -1.950 V VCC = 0.0 V	<u>3</u> /		1, 3	0.5 0.3		μА
Functional tests		See 4.3.1c			7,8			
See footnotes at end of	table.							
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TABLE I. Electrical performance characteristics - Continued. Limits Unit Group A Test Symbol | Conditions -55°C < TA < +125°C unless otherwise specified subgroups Min Max Rapid tests 4/ Case 2 VIL. VIH High level output HOV Outputs voltage terminated -1.027 -0.799 ٧ -1.950 -0.799 1 through -0.8791 -0.670 2 100Ω to -2 V -0.670 -1.950 VCC = 0.0 V VEE = -5.2 V -1.079 -0.860 -0.860 -1.9503 -1.586 -1.950 -1.950 VOL -0.799 1 Low level output -1.950 -1.570 ٧ -0.670 -1.950 2 voltage -0.860 -1.950 -1.616 -1.950 3 -1.027 -1.127 -1.486 -0.7991High level threshold VOHA 1 -0.670 ٧ -0.979 | -1.471 2 -0.879| output voltage -1.179 | -1.516 3 -1.0791 -0.860| -1.127 | -0.979 | -1.486 -1.470 -1.950 -1.586 1 2 Low level threshold VOLA -1.950 -1.570 ٧ output voltage -1.950 -1.616 -1.179 | -1.516 3 VEE = -5.46 V VCC = 0.0 V VIH = -0.799 V at +25°C -0.670 V at +125°C mΑ -41 -45 Power supply drain 3/ 2, 3 IEE -0.860 V at -55°C 1,2 295 μΑ High level input IIH 480 current VEE = -4.94 V VIL = -1.950 V 3/ VCC = 0.0 V 0.5 0.3 μΑ 1, 3 Low level input current IIL See 4.3.1c 7,8 Functional tests See footnotes at end of table. **STANDARDIZED** SIZE A 5962-87509 MILITARY DRAWING E ELECTRONICS SUPPLY CENTER REVISION LEVEL SHEET 6 DAYTON, OHIO 45444

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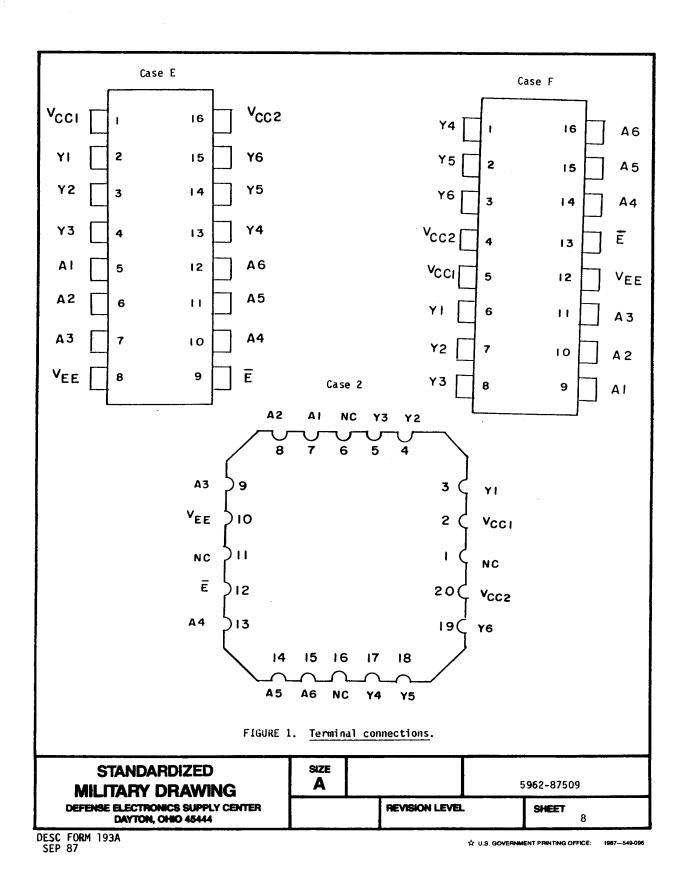
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Test	Symbol	Conditions	Group A	Limits		Unit
	 	-55°C < TA < +125°C unless otherwise specified	subgroups	Min	Max	
Cases E, F, and 2	<u>' , , , , , , , , , , , , , , , , , , ,</u>	AC tests				
Transition time	tTLH tTHL	V _{EE} = -2.94 V V _{CC} = 2.0 V CL < 5 pF	9 10 11	0.70 0.70 0.70	2.20 2.40 2.20	ns
Propagation delay time, A to Y	t _{PHH} ,	R _L = 100Ω See figure 4 	9 10 11	0.70 0.70 0.70	1.70 1.90 1.70	 ns
Propagation delay time, E to Y	t _{PLH}		9 10 11	0.70 0.70 0.70	2.60 2.80 2.50	ns

- 1/ The quiescent limits are determined after a device has reached thermal equilibrium. This is defined as the reading taken with the device in a socket with > 500 LFPM of +25°C, +125°C, or -55°C (as applicable), air blowing on the unit in a transverse direction with power applied for at least 4 minutes before the reading is taken. This method was used for theoretical limit establishment only. All devices shall be tested to the delta V (rapid test) conditions specified herein. The rapid test method is an equivalent method of testing quiescent conditions.
- $^{2/}$ The high and low level output current varies with temperature and shall be calculated using the following formulas: I_{OH} = (V $_{OH}$ 2 V)/100 $_{\Omega}$, and I_{OL} = (V $_{OL}$ 2 V)/100 $_{\Omega}$.
- 3/ The IEE and IIL limits, although specified in the minimum column, shall not be exceeded, in magnitude, as a maximum value.
- 4/ The dc rapid test forcing functions and limits are used for all dc testing. These limits are determined for each device type based on the power dissipation and package type. The rapid test (delta V) limits and forcing functions are skewed allowing rapid testing to be performed at standard temperatures without the addition of delta T's.
- 3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

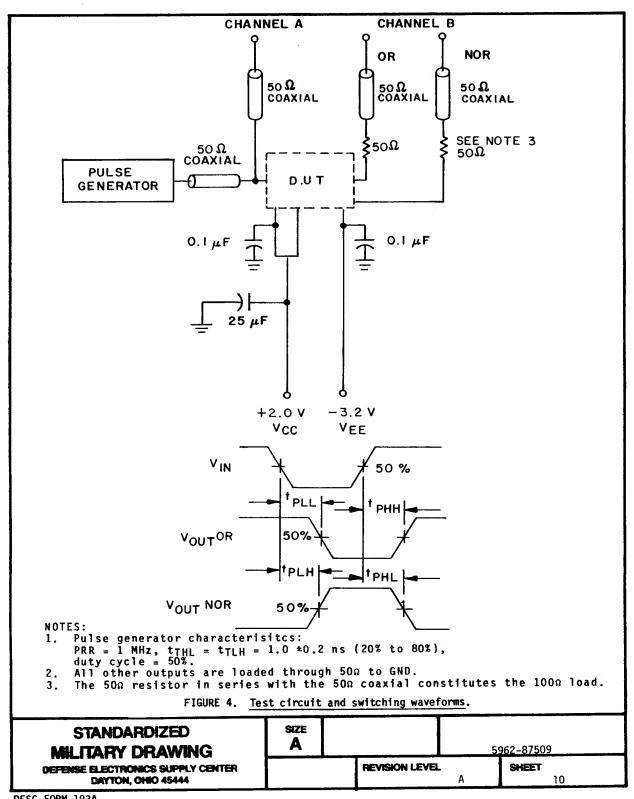
STANDARDIZED MILITARY DRAWING	SIZE	_ i			5962-87509	
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Inputs Output Ē Y L L = Low level voltage
H = High level voltage FIGURE 2. Truth table. Ē - YI Αi . Y2 A2 _ **Y3** A5 -Α6 FIGURE 3. Logic diagram. SIZE **STANDARDIZED** A 5962-87509 **MILITARY DRAWING** DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444 **REVISION LEVEL** SHEET 9 Α

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4. QUALITY ASSURANCE PROVISIONS

- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-SID-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 4, 5, and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - c. Subgroups 7 and 8 tests shall verify the truth table specified on figure 2 herein.
 - 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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TABLE II.	Electrical	test requirements	
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MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	1
Final electrical test parameters (method 5004)	1*, 2, 3, 7*, 8, 9
Group A test requirements (method 5005)	1, 2, 3, 7, 8, 9, 10, 11
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3

^{*} PDA applies to subgroups 1 and 7.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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6.4 Approved source of supply. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor similar part <u>1</u> / number		
5962-8750901EX	04713	10H588/BEAJC		
5962-8750901FX	04713	10H588/BFAJC		
5962-87509012X	04713	 10H588M/B2AJC		

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Yendor CAGE number

04713

Vendor name and address

Motorola, Incorporated 7402 South Price Road Tempe, AZ 85283

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